

Search Notes

Application/Control No.

10/064,581

Examiner

John D. Lee

Applicant(s)/Patent under
Reexamination

BALCH ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
385	14,129- 132,147	6/8/2005	JDL
430	321-326	6/8/2005	JDL
700	117-121	6/8/2005	JDL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Files	Removed	6/8/2005	JDL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO "WEST" Database searched; search strategy on separate sheet.	6/8/2005	JDL